


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/533,263	WALKOE ET AL.	
	Examiner	Art Unit	
	Ricardo Pizarro	2661	

ISSUE CLASSIFICATION							
ORIGINAL				CROSS REFERENCE(S)			
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
370	419	370	352				
INTERNATIONAL CLASSIFICATION							
H04L 12/28							
Ricardo Pizarro 2/27/00 (Assistant Examiner) (Date)				HASSAN KIZOU SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 (Primary Examiner) (Date)		Total Claims Allowed: 8	
P. Delonch (Legal Instruments Examiner) (Date)						O.G. Print Claim(s) 1	O.G. Print Fig. 5

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant										<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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